# Localized Phase Contrast Imaging Measurements at Wendelstein 7-X 

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Localized phase contrast imaging (PCI) measurements at the Wendelstein 7-X (W7-X) stellarator have been carried out using the masking technique pioneered at the Heliotron E stellarator [1] and the DIII-D tokamak [2]. The masking technique relies on the fact that turbulent fluctuations in magnetically confined plasmas generally have wave vectors, $\mathbf{k}$, which are almost perpendicular to the background magnetic field, $\mathbf{B}[1,2]$. When this is combined with the lineintegrated nature of PCI measurements [1, 2, 3, 4, 5], which makes the observed $\mathbf{k}$ perpendicular to the line-of-sight (LoS) of the PCI laser beam, the direction of the $\mathbf{k}$ observed by PCI becomes a function of the pitch angle of $\mathbf{B}[1,2,2]$. As illustrated in Fig. 1, the beam pattern in a focal plane of the plasma, caused by scattering off a fluctuation with wave vector $\mathbf{k}$, consists of an unscattered beam spot and two scattered beam spots with the same shape as the unscattered one, but shifted by vectors $\propto \pm \mathbf{k}[1,2]$. It is therefore possible to obtain PCI measurements from a limited range of $\mathbf{B}$ pitch angles, corresponding to a limited part of the PCI LoS, by placing a mask in a focal of the PCI system, which cuts off the scattered beam spots for $\mathbf{k}$ outside the desired range of $\mathbf{B}$ pitch angles [1, 2].

The ability to obtain localized PCI measurements depends critically on the unscattered beam spot size in the focal plane where the localization mask is placed, as a scattered beam spot covering a half-angle of $\Delta \theta$ will contribute to the signal for $\mathbf{B}$ pitch angles within $\pm \Delta \theta$ of the one corresponding to its own $\mathbf{k}$; this is illustrated in Fig. 1. To facilitate long-pulse operation, the portliner around the PCI laser beam at W7-X has been reduced in size, from previously having a radius of $a=68 \mathrm{~mm}$, to $a=42 \mathrm{~mm}$ in the most recent experimental campaign [5]. Since the new $a$ is similar to the typical $1 /$ e electric field radius of the Gaussian beam used for PCI at W7-X, $W=40 \mathrm{~mm}$, it is of interest to determine the limit of the spot size in the focal plane imposed by the portliner. To do this, we note that, within a Fraunhofer diffraction framework, the beam pattern in the focal plane can be modeled by the Fourier transform of the truncated Gaussian, $\mathbf{E}_{0}^{a}=\mathbf{C}_{0} \Theta(a-r) \mathrm{e}^{-r^{2} / W^{2}}$, where $\mathbf{C}_{0}$ is the beam amplitude vector, $\Theta$ is the Heaviside function, and $r$ is the distance from the beam axis. Defining the Fourier transform as
 being the corresponding focal plane wave vector, while noting that the intensity is $\propto\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2}$, we find

$$
\begin{equation*}
\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2}\left(k^{\prime}\right)=4 \pi^{2} C_{0}^{2}\left[\int_{0}^{a} r J_{0}\left(k^{\prime} r\right) \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right]^{2} \tag{1}
\end{equation*}
$$

where $J_{0}\left(k^{\prime} r\right)=[1 /(2 \pi)] \int_{0}^{2 \pi} \mathrm{e}^{-\mathrm{i} k^{\prime} r \cos (\theta)} \mathrm{d} \theta$ is a Bessel function of the first kind of order zero and $k^{\prime}=\left|\mathbf{k}^{\prime}\right|, C_{0}=\left|\mathbf{C}_{0}\right|$. When $a \rightarrow \infty,\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2}\left(k^{\prime}\right) \rightarrow \pi^{2} C_{0}^{2} W^{4} \mathrm{e}^{-k^{\prime 2} W^{2} / 2}$, showing that the size of the non-truncated Gaussian beam spot is $\propto 1 / W$. To compare the spot size with the portliner present to the Gaussian case, we fit Eq. (1) by a Gaussian function

$$
\begin{equation*}
\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}\left(k^{\prime}\right)=\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}(0) \mathrm{e}^{-k^{\prime 2} W_{\mathrm{eff}}^{2} / 2} \tag{2}
\end{equation*}
$$

we also note that the $1 / \mathrm{e}$ beam spot radius of Eq. (2) in $\mathbf{k}^{\prime}$ space is $\sqrt{2} / W_{\text {eff }}$ and use this as a measure of the beam spot size in Fig. 1. Optimally, we would perform a least square fit of Eq. (2) to Eq. (1), while enforcing conservation of the power transported by the beam, i.e., $\int_{\text {all } \mathbf{k}^{\prime}}\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2} \mathrm{~d} \mathbf{k}^{\prime}=\int_{\text {all }} \mathbf{k}^{\prime}\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2} \mathrm{~d} \mathbf{k}^{\prime}$. Such a fit does, however, not admit a general closed form of $W_{\text {eff }}$ and we shall therefore instead fit Eq. (1) by matching its Maclaurin series to that of Eq. (2) up to second order, which yields a simple analytical expression for $W_{\text {eff. }}$. This method will match the least square fit in the limit of $W / a \rightarrow 0$, as both Eqs. (1) and (2) are Gaussian functions in that case. Even in the case of $W / a \rightarrow \infty$, the $W_{\text {eff }}$ obtained by matching the Maclaurin series of Eqs. (1) and (2) up to second order only deviates from the least square fit conserving the beam power by $2.2 \%$ [6]. Matching the zeroth order terms of the Maclaurin series yields the fit amplitude,

$$
\begin{equation*}
\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}(0)=\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2}(0)=4 \pi^{2} C_{0}^{2}\left[\int_{0}^{a} r \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right]^{2}=\pi^{2} C_{0}^{2} W^{4}\left(1-\mathrm{e}^{-a^{2} / W^{2}}\right)^{2} \tag{3}
\end{equation*}
$$

The first order term of the series is obtained by differentiating Eq. (1) with respect to $k^{\prime}$,

$$
\begin{equation*}
\frac{\partial\left|\hat{\mathbf{E}}_{a}\right|^{2}\left(k^{\prime}\right)}{\partial k^{\prime}}=-8 \pi^{2} C_{0}^{2}\left[\int_{0}^{a} r J_{0}\left(k^{\prime} r\right) \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right]\left[\int_{0}^{a} r^{2} J_{1}\left(k^{\prime} r\right) \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right] \tag{4}
\end{equation*}
$$

where $J_{1}$ is a Bessel function of the first kind of order one. Since $J_{1}(0)=0$, it is clear that $\partial\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2}\left(k^{\prime}\right) /\left.\partial k\right|_{k^{\prime}=0}=0$. Differentiating Eq. [2], $\partial\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}\left(k^{\prime}\right) / \partial k^{\prime}=-k^{\prime} W_{\text {eff }}^{2}\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}(0) \mathrm{e}^{-k^{2} W_{\mathrm{eff}}^{2} / 2}$, so $\partial\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}\left(k^{\prime}\right) /\left.\partial k^{\prime}\right|_{k^{\prime}=0}=0$, meaning that the first order terms of the Maclaurin series will match regardless of the fit parameters, as both Eqs. (1) and (2) have stationary points at $k^{\prime}=0$. To obtain the second order term of the series, we differentiate Eq. (4) with respect to $k^{\prime}$,

$$
\begin{align*}
\frac{\partial^{2}\left|\hat{\mathbf{E}}_{a}\right|^{2}\left(k^{\prime}\right)}{\partial k^{\prime 2}}=8 \pi^{2} C_{0}^{2}\left(\left[\int_{0}^{a} r^{2} J_{1}\left(k^{\prime} r\right) \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right]^{2}-\right. & {\left[\int_{0}^{a} r J_{0}\left(k^{\prime} r\right) \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right] }  \tag{5}\\
\times & \left.\left\{\int_{0}^{a} r^{3}\left[J_{0}\left(k^{\prime} r\right)-\frac{J_{1}\left(k^{\prime} r\right)}{k^{\prime} r}\right] \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right\}\right)
\end{align*}
$$



Figure 1: Beam pattern due to scattering off fluctuation with wave vector $\mathbf{k}$ in a focal plane. The scattered beam spots have the same shape as the unscattered one and their separations from it are $\propto \pm \mathbf{k}$.


Figure 2: $2 W_{\text {eff }}$ from Eq. (7) for the new (solid line) and old (dashed line) $a$ at W7-X, along with $2 W$ (dashed-dotted line) and the new/old $\sqrt{2} a$ (dotted lines), versus $2 W$. For $2 W<a$, $2 W_{\text {eff }} \approx 2 W$, while $2 W_{\text {eff }} \rightarrow \sqrt{2} a$ for $2 W>3 a$.

Next, we evaluate Eq. (5) for $k^{\prime} \rightarrow 0$, recalling that $J_{1}\left(k^{\prime} r\right) /\left(k^{\prime} r\right) \rightarrow 1 / 2$ when $k^{\prime} r \rightarrow 0$,

$$
\begin{align*}
\left.\frac{\partial^{2}\left|\hat{\mathbf{E}}_{a}\right|^{2}\left(k^{\prime}\right)}{\partial k^{\prime 2}}\right|_{k^{\prime}=0} & =-4 \pi^{2} C_{0}^{2}\left(\int_{0}^{a} r \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right)\left(\int_{0}^{a} r^{3} \mathrm{e}^{-r^{2} / W^{2}} \mathrm{~d} r\right)  \tag{6}\\
& =-\pi^{2} C_{0}^{2} W^{6}\left(1-\mathrm{e}^{-a^{2} / W^{2}}\right)\left[1-\left(1+a^{2} / W^{2}\right) \mathrm{e}^{-a^{2} / W^{2}}\right]
\end{align*}
$$

We further note that $\partial^{2}\left|\hat{\mathbf{E}}_{\text {fit }}\right|^{2}\left(k^{\prime}\right) / \partial k^{\prime 2}=\left(k^{2} W_{\text {eff }}^{2}-1\right) W_{\text {eff }}^{2}\left|\hat{\mathbf{E}}_{\text {fit }}\right|^{2}(0) \mathrm{e}^{-k^{2} W_{\text {eff }}^{2} / 2}$. Combining this with Eq. (3) yields $\partial^{2}\left|\hat{\mathbf{E}}_{\mathrm{fit}}\right|^{2}\left(k^{\prime}\right) /\left.\partial k^{\prime 2}\right|_{k^{\prime}=0}=-\pi^{2} C_{0}^{2} W^{4} W_{\mathrm{eff}}^{2}\left(1-\mathrm{e}^{-a^{2} / W^{2}}\right)^{2}$, which finally allows us to compute $W_{\text {eff }}$ by setting $\partial^{2}\left|\hat{\mathbf{E}}_{\text {fit }}\right|^{2}\left(k^{\prime}\right) /\left.\partial k^{\prime 2}\right|_{k^{\prime}=0}=\partial^{2}\left|\hat{\mathbf{E}}_{0}^{a}\right|^{2}\left(k^{\prime}\right) /\left.\partial k^{\prime 2}\right|_{k^{\prime}=0}$,

$$
\begin{equation*}
W_{\mathrm{eff}}=W \sqrt{1-\frac{a^{2} / W^{2}}{\mathrm{e}^{a^{2} / W^{2}}-1}} . \tag{7}
\end{equation*}
$$

For $a^{2} / W^{2} \rightarrow \infty, W_{\text {eff }} \rightarrow W$, as expected. When $a^{2} / W^{2} \rightarrow 0, W_{\text {eff }} \rightarrow a / \sqrt{2}$, in agreement with the corresponding estimate of [6]. At W7-X, $a / \sqrt{2}=29.7 \mathrm{~mm}$, while the least square fit $W_{\text {eff }}$ conserving the beam power is $0.723 a=30.4 \mathrm{~mm}$ [6], illustrating the closeness of the two fits. Figure 2 shows $2 W_{\text {eff }}$ for the old and new $a$ at W7-X, along with $2 W$ and $\sqrt{2} a$ for the old/new $a$, versus $2 W$ up to a value of 140 mm , which is the maximum beam size allowed by the W7-X PCI system [3]. From Fig. 2, we conclude that $2 W_{\text {eff }} \approx 2 W$ for $2 W<a$, while $2 W_{\text {eff }}$ increases significantly slower than $2 W$ for $2 W_{\text {eff }}>a$, and approaches the asymptotic limit of $\sqrt{2} a$ for $2 W>3 a$. Although $2 W>a$ for the typical PCI laser beam size at W7-X $(2 W=80 \mathrm{~mm})$ with both the new and old $a$, we note that the reduction of $2 W_{\text {eff }}$ relative to $2 W$ is more significant
for the new $a\left(2 W_{\text {eff }}=53.8 \mathrm{~mm}\right)$ than for the old $a\left(2 W_{\text {eff }}=72.9 \mathrm{~mm}\right)$, as expected. The above results make it possible to determine a lower limit of the $\mathbf{B}$ pitch angle which can be resolved by cutting off part of the beam in the focal plane. Using the geometry of Fig. 11, with the assumption of small $\Delta \theta$ and the fact that $W_{\text {eff }}<0.723 a$, we find

$$
\begin{equation*}
\Delta \theta \approx \frac{\sqrt{2}}{k W_{\mathrm{eff}}}>\frac{1.956}{k a} \tag{8}
\end{equation*}
$$

Equation (8) illustrates that it is generally easier to localize modes with larger $k$, as their scattered beam spots cover a smaller angle, in agreement with [1, 2] and Fig. [1. The experimental $\Delta \theta$ limit is expected to be somewhat larger than that of Eq. (8) due to diffraction effects beyond the Fraunhofer model [2], but Eq. (8) still serves as an ultimate lower bound. For the new typical effective beam radius at $\mathrm{W} 7-\mathrm{X}\left(W_{\text {eff }}=26.9 \mathrm{~mm}\right)$ and ion temperature gradient (ITG) driven modes around $k \approx 6 \mathrm{~cm}^{-1}$, which have the largest linear growth rate for standard electron cyclotron resonance heated plasmas at W7-X [4], $2 \Delta \theta \approx 10^{\circ}$ from Eq. (8). On the other hand, the variation of the pitch angle of $\mathbf{B}$ along the PCI LoS ranges from $15^{\circ}$ to $20^{\circ}$ on the outboard side of W7-X in different magnetic configurations [3]. Using these estimates, we thus see that localization of typical ITG turbulence PCI features down to half the minor radius is feasible on the outboard side of W7-X. On inboard side of W7-X, the variation of the pitch angle of $\mathbf{B}$ along the PCI LoS is approximately $5^{\circ}$ in all magnetic configurations [3] and the ability to obtain localized PCI measurements on the inboard side is rather limited as a result. Detailed results related to the W7-X PCI localization masks will be presented in a future publication.

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